

<b>Notice of References Cited</b>	Application/Control No. 10/044,615	Applicant(s)/Patent Under Reexamination MILLER ET AL.	
	Examiner Devon C Kramer	Art Unit 3683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,505,281	04-1996	Lee, W. Ken	188/299.1
	B	US-6,305,512	10-2001	Heinz et al.	188/299.1
	C	US-5,924,528	07-1999	Vermolen et al.	188/266.1
	D	US-5,038,897	08-1991	Wells et al.	188/282.1
	E	US-5,725,239	03-1998	de Molina, Simon Anne	280/5.503
	F	US-5,207,300	05-1993	Engel et al.	188/266.2
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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